

Search Notes

Application/Control No.

10/604,174

Examiner

Sun J. Lin

Applicant(s)/Patent under
Reexamination

JENKINS ET AL.

Art Unit

2825

SEARCHED

Class	Subclass	Date	Examiner
716	13	5/25/2005	JSL
716	12	5/25/2005	JSL
716	14	5/25/2005	JSL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
716	13	5/25/2005	JSL
716	12	5/25/2005	JSL
716	14	5/25/2005	JSL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
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EAST
[USPAT;US-PGPUB]

5/25/2005

JSL

EAST
[UPO;JPO;DERWENT;IBM_TDB=

5/25/2005

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IEEE

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